

SOT-23 Plastic-Encapsulate Transistors**MMBT3904**

TRANSISTOR (NPN)

FEATURES

- As complementary type the PNP transistor MMBT3906 is recommended
- Epitaxial planar die construction

MARKING: 1AM**MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise noted)**

Symbol	Parameter	Value	Units
V_{CBO}	Collector-Base Voltage	60	V
V_{CEO}	Collector-Emitter Voltage	40	V
V_{EBO}	Emitter-Base Voltage	6	V
I_c	Collector Current -Continuous	200	mA
P_c	Total Device Dissipation	200	mW
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	625	°C/W
T_J	Junction Temperature	150	°C
T_{stg}	Storage Temperature	-55 to +150	°C

**ELECTRICAL CHARACTERISTICS (Tamb=25°C unless otherwise specified)**

Parameter	Symbol	Test conditions	MIN	MAX	UNIT
Collector-base breakdown voltage	V_{CBO}	$I_C= 10\mu\text{A}, I_E=0$	60		V
Collector-emitter breakdown voltage	V_{CEO}	$I_C= 1\text{mA}, I_E=0$	40		V
Emitter-base breakdown voltage	V_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6		V
Collector cut-off current	I_{CBO}	$V_{CB}=60\text{V}, I_E=0$		0.1	μA
Collector cut-off current	I_{CEX}	$V_{CE}=30\text{V}, V_{BE(\text{off})}=3\text{V}$		50	nA
Emitter cut-off current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$		0.1	μA
DC current gain	$h_{FE(1)}$	$V_{CE}=1\text{V}, I_C=10\text{mA}$	100	400	
	$h_{FE(2)}$	$V_{CE}=1\text{V}, I_C= 50\text{mA}$	60		
	$h_{FE(3)}$	$V_{CE}=1\text{V}, I_C= 100\text{mA}$	30		
Collector-emitter saturation voltage	$V_{CE(\text{sat})}$	$I_C=50\text{mA}, I_B= 5\text{mA}$		0.3	V
Base-emitter saturation voltage	$V_{BE(\text{sat})}$	$I_C= 50\text{mA}, I_B= 5\text{mA}$		0.95	V
Transition frequency	f_T	$V_{CE}=20\text{V}, I_C=10\text{mA}, f=100\text{MHz}$	300		MHz
Delay Time	td	$V_{CC}=3\text{V}, V_{BE}=-0.5\text{V}$ $I_C=10\text{mA}, I_{B1}=-I_{B2}=1.0\text{mA}$		35	nS
Rise Time	tr			35	nS
Storage Time	ts	$V_{CC}=3\text{V}, I_C=10\text{mA},$ $I_{B1}=-I_{B2}=1\text{mA}$		200	nS
Fall Time	tf			50	nS

CLASSIFICATION OF $h_{FE(1)}$

Rank	O	Y	G
Range	100-200	200-300	300-400